


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566583	<b>Applicant(s)/Patent Under Reexamination</b>  KAMEDA, FUTOSHI
	<b>Examiner</b>  LINDSAY M LOW	<b>Art Unit</b>  3721

SEARCHED			
Class	Subclass	Date	Examiner
227	107, 119, 120, 135, 139	7/23/2007	LL
UPDATED		1/6/2008	LL
UPDATED		6/18/2008	LL
UPDATED		12/10/2008	LL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--